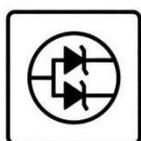


MSKSEMI 美森科

SEMICONDUCTOR



ESD



TVS



TSS



MOV



GDT



PLED

2SA1015-MS

Product specification

FEATURES

- High voltage and high current
- Excellent hFE Linearity
- Low noise
- Complementary to 2SC1815-MS

Reference News

PACKAGE OUTLINE	MARKING
 <p>1. BASE 2. EMITTER 3. COLLECTOR</p>	
SOT-23	

MAXIMUM RATINGS (Ta=25°C unless otherwise noted)

Symbol	Parameter	Value	Unit
V _{CB0}	Collector-Base Voltage	-50	V
V _{CEO}	Collector-Emitter Voltage	-50	V
V _{EBO}	Emitter-Base Voltage	-5	V
I _c	Collector Current -Continuous	150	mA
P _c	Collector Power Dissipation	200	mW
R _{θJA}	Thermal Resistance From Junction To Ambient	625	°C/W
T _J	Junction Temperature	150	°C
T _{stg}	Storage Temperature	-55~+150	°C

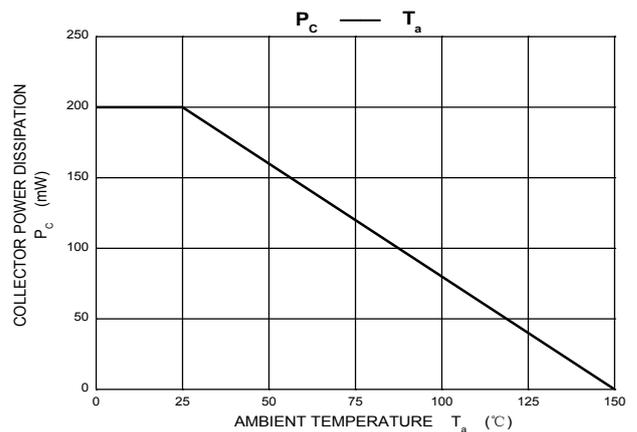
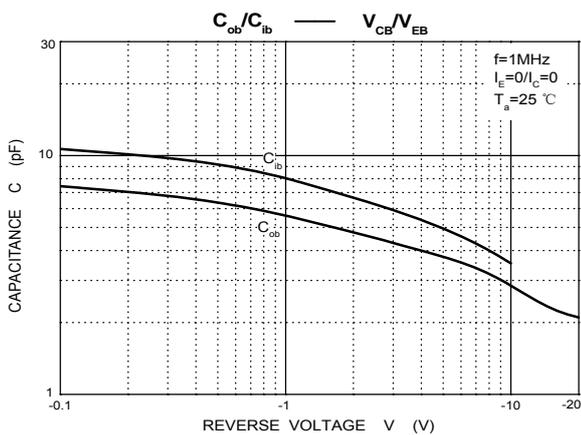
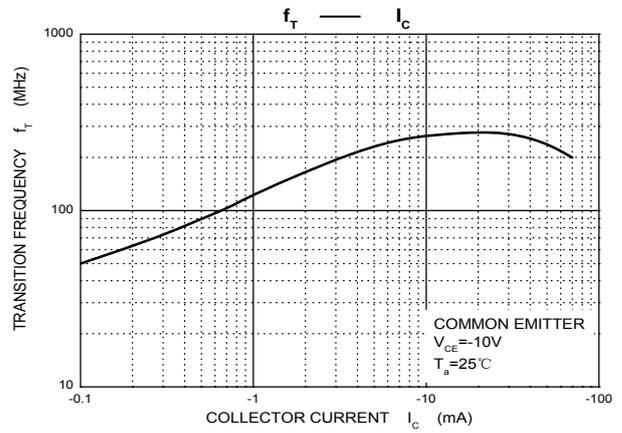
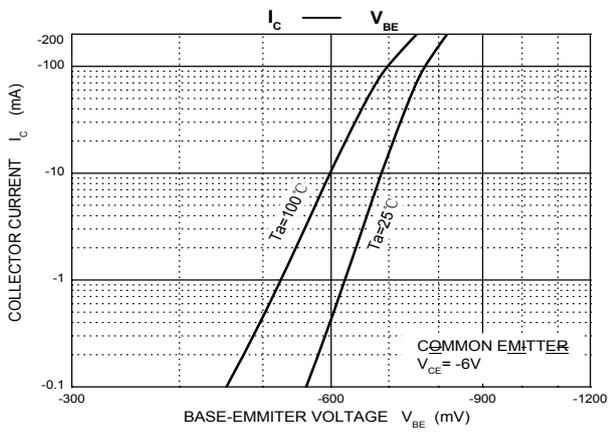
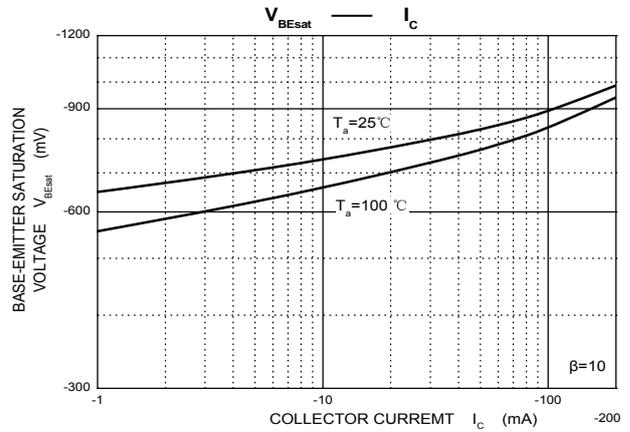
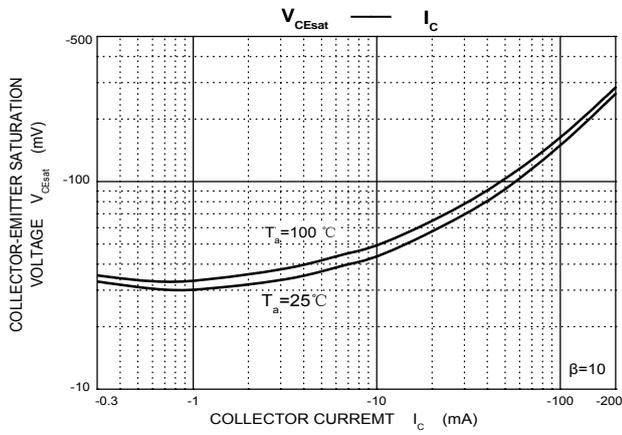
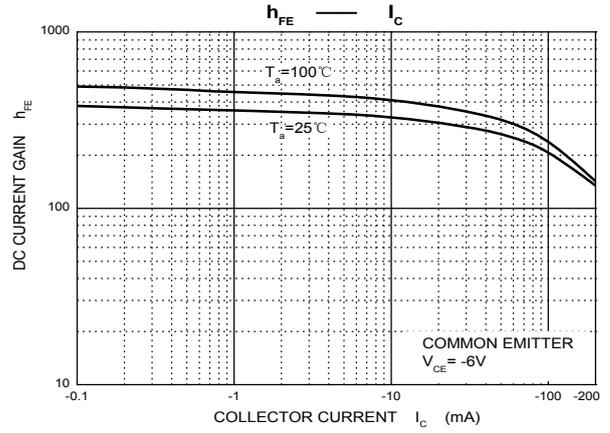
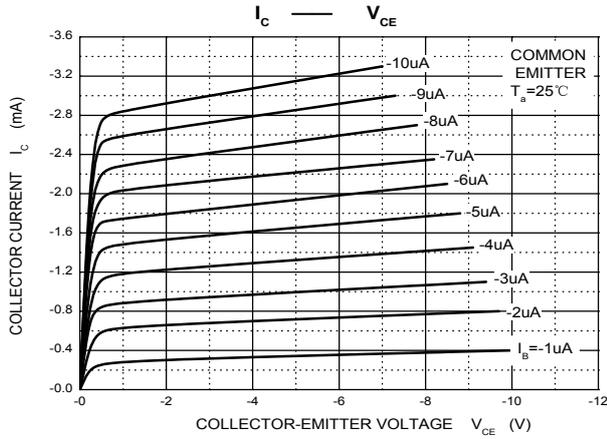
ELECTRICAL CHARACTERISTICS (Ta=25°C unless otherwise specified)

Parameter	Symbol	Test conditions	Min	Typ	Max	Unit
Collector-base breakdown voltage	V _{(BR)CBO}	I _c = -100μA, I _E =0	-50			V
Collector-emitter breakdown voltage	V _{(BR)CEO}	I _c = -0.1mA, I _B =0	-50			V
Emitter-base breakdown voltage	V _{(BR)EBO}	I _E = -100 μ A, I _C =0	-5			V
Collector cut-off current	I _{CBO}	V _{CB} =-50V, I _E =0			-0.1	μA
Collector cut-off current	I _{CEO}	V _{CE} = -50V, I _B =0			-0.1	μA
Emitter cut-off current	I _{EBO}	V _{EB} =- 5V, I _C =0			-0.1	μA
DC current gain	h _{FE}	V _{CE} =-6V, I _c = -2mA	130		400	
Collector-emitter saturation voltage	V _{CE(sat)}	I _c =-100 mA, I _B = -10mA			-0.3	V
Base-emitter saturation voltage	V _{BE(sat)}	I _c =-100 mA, I _B = -10mA			-1.1	V
Transition frequency	f _T	V _{CE} =-10V, I _c = -1mA f=30MHz	80			MHz

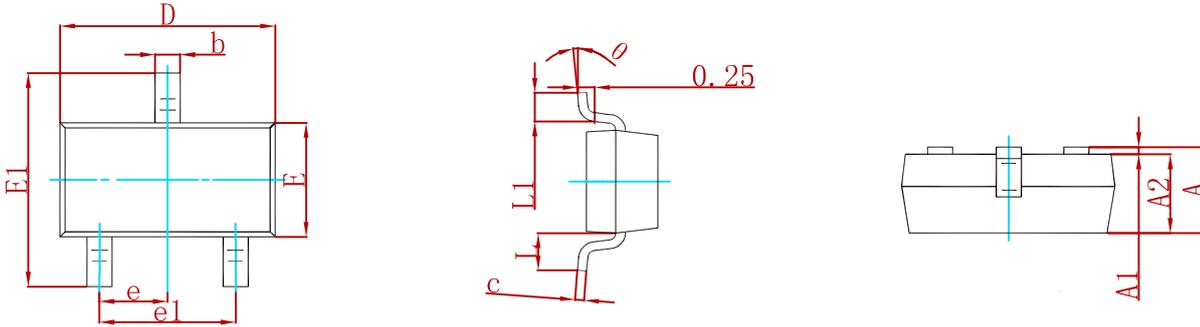
CLASSIFICATION OF h_{FE}

Rank	L	H
Range	130-200	200-400

BIPOLAR TRANSISTOR (PNP) Typical Characteristics

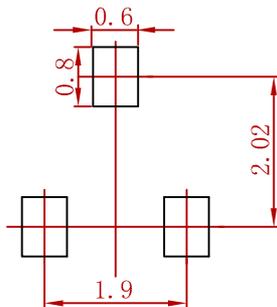


PACKAGE MECHANICAL DATA



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min	Max	Min	Max
A	0.900	1.150	0.035	0.045
A1	0.000	0.100	0.000	0.004
A2	0.900	1.050	0.035	0.041
b	0.300	0.500	0.012	0.020
c	0.080	0.150	0.003	0.006
D	2.800	3.000	0.110	0.118
E	1.200	1.400	0.047	0.055
E1	2.250	2.550	0.089	0.100
e	0.950 TYP		0.037 TYP	
e1	1.800	2.000	0.071	0.079
L	0.550 REF		0.022 REF	
L1	0.300	0.500	0.012	0.020
θ	0°	8°	0°	8°

Suggested Pad Layout



Note:
 1. Controlling dimension: in millimeters.
 2. General tolerance: ± 0.05mm.
 3. The pad layout is for reference purposes only.

REEL SPECIFICATION

P/N	PKG	QTY
2SA1015-MS	SOT-23	3000

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